# Hypothesis tests

Aldo Solari Statistical Inference II PhD in Economics, Statistics and Data Science University of Milano-Bicocca



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Outline

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#### Main references

– Cox and Hinkley (1976) Theoretical Statistics. Chapman and Hall/CRC,  $\S 4, \, \S 5$ 

The Neyman–Pearson formulation of hypothesis testing requires to fix the probability of rejecting  $H_0$  when it is true, denoted by  $\alpha$ , aiming to maximize the probability of rejecting  $H_1$  when false.

This approach demands the explicit formulation of the *alternative*  $hypothesis H_1$ .

The decision procedure, i.e. rejecting or not  $H_0$ , is called the *test* of  $H_0$  against  $H_1$ .

Suppose *Y* has distribution  $f_Y(y; \theta)$  for  $\theta \in \Theta$ 

Formulate a null hypothesis  $H_0: \theta \in \Theta_0$  and an alternative hypothesis  $H_1: \theta \in \Theta_1$  with  $\Theta_0 \cup \Theta_1 = \Theta$  and  $\Theta_0 \cap \Theta_1 = \emptyset$ 

A *test* or *critical function*  $\phi = \phi(Y)$  assigns to each possible value y one of these two decisions

$$\phi: \mathcal{Y} \mapsto \{0,1\}$$

where 1 denotes the decision of rejecting  $H_0$  and 0 denotes the decision of not rejecting  $H_0$ , and thereby partition the sample space  $\mathcal{Y}$  into two complementary regions  $\mathcal{Y}_0$  and  $\mathcal{Y}_1$ 

When performing a test one may arrive at the correct decision, or one may commit one of two errors: rejecting  $H_0$  when it is true (*type I error*) or not rejecting it when it is false (*type II error*).

# Critical region

Unfortunately, the probabilities of the two types of error cannot be controlled simultaneously

Choose the *level of significance*  $\alpha \in (0, 1)$ , and control the probability of type I error at  $\alpha$ , i.e.

$$\operatorname{pr}_{\theta}(Y \in \mathcal{Y}_1) \le \alpha \quad \forall \ \theta \in \Theta_0$$

The *size* of the test is

$$\sup_{\theta \in \Theta_0} \operatorname{pr}_{\theta}(Y \in \mathcal{Y}_1)$$

If, for all  $\alpha$ , the size of the test is  $\alpha$ , we call  $\mathcal{Y}_1$  a *critical region of size*  $\alpha$ , denoted by  $\mathcal{Y}_{\alpha}$ 

#### Power function

Subject to

$$\sup_{\theta \in \Theta_0} \operatorname{pr}_{\theta}(Y \in \mathcal{Y}_{\alpha}) = \alpha$$

it is desired to maximize

$$\operatorname{pr}_{\theta}(Y \in \mathcal{Y}_{\alpha}) \quad \forall \ \theta \in \Theta_1$$

Considered as a function of  $\theta$ , this probability is called the *power* function of the test

$$pow(\theta; \alpha) = pr_{\theta}(Y \in \mathcal{Y}_{\alpha}; \theta)$$

### *p*-value

If we require that the rejection regions  $\mathcal{Y}_{\alpha}$  and  $\mathcal{Y}_{\tilde{\alpha}}$  are *nested* in the sense that

$$\mathcal{Y}_{\alpha} \subset \mathcal{Y}_{\tilde{\alpha}}$$
 if  $\alpha < \tilde{\alpha}$ 

the p-value is defined as the smallest significance level at which the null hypothesis would be rejected for the given observation:

$$p_{\text{obs}} = \inf\{\alpha : y \in \mathcal{Y}_{\alpha}\}\$$

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In the present section we consider only the case where  $H_0$  is a simple hypothesis

It is best to begin with a simple alternative hypothesis  $H_1$ 

$$H_0: Y \sim f_0(y), \quad H_1: Y \sim f_1(y)$$

Let  $\mathcal{Y}_{\alpha}$  and  $\mathcal{Y}'_{\alpha}$  be two critical region of size  $\alpha$ , i.e.

$$\operatorname{pr}_0(Y \in \mathcal{Y}_\alpha) = \operatorname{pr}_0(Y \in \mathcal{Y}'_\alpha)$$
 (1)

We regard  $\mathcal{Y}_{\alpha}$  as preferable to  $\mathcal{Y}'_{\alpha}$  for the alternative  $H_1$  if

$$\operatorname{pr}_1(Y \in \mathcal{Y}_{\alpha}) > \operatorname{pr}_1(Y \in \mathcal{Y}'_{\alpha})$$
 (2)

The region  $\mathcal{Y}_{\alpha}$  is called the *critical region* of size  $\alpha$  if (2) is satisfied for all other  $\mathcal{Y}'_{\alpha}$  satisfying the size condition (1).

We call  $\operatorname{pr}_1(Y \in \mathcal{Y}_\alpha)$  the *size*  $\alpha$  *power* of the test against  $H_1$ 

## Neyman-Pearson lemma

For simplicity, suppose that the likelihood ratio  $lr(Y) = f_1(Y)/f_0(Y)$  is, under  $H_0$ , a continuous random variable such that for all  $\alpha$ , there exists a unique  $c_{\alpha}$  such that

$$\operatorname{pr}_0(\operatorname{lr}(Y) \ge c_\alpha) = \alpha$$

We call the region defined by

$$lr(y) \ge c_{\alpha}$$

the size  $\alpha$  likelihood ratio critical region

A fundamental result, called the Neyman-Pearson lemma, is that, for any size  $\alpha$ , the likelihood ratio critical region is the best critical region.

Let  $\mathcal{Y}_{\alpha}$  be the likelihood ratio critical region and let  $\mathcal{Y}_{1}$  be any other critical region, both being of size  $\alpha$ . Then

$$\alpha = \int_{\mathcal{V}_0} f_0(y) dy = \int_{\mathcal{V}_1} f_0(y) dy$$

so that

$$\int_{\mathcal{Y}_{\alpha}\setminus\mathcal{Y}_{1}}f_{0}(y)dy=\int_{\mathcal{Y}_{1}\setminus\mathcal{Y}_{\alpha}}f_{0}(y)dy$$

since 
$$\int_{\mathcal{Y}_{\alpha}} f_0(y) dy = \int_{\mathcal{Y}_{\alpha} \setminus \mathcal{Y}_1} f_0(y) dy + \int_{\mathcal{Y}_{\alpha} \cap \mathcal{Y}_1} f_0(y) dy$$

Now, if  $y \in \mathcal{Y}_{\alpha} \setminus \mathcal{Y}_{1}$ , which is inside  $\mathcal{Y}_{\alpha}$ ,  $f_{1}(y) \geq c_{\alpha}f_{0}(y)$ , while if  $y \in \mathcal{Y}_{1} \setminus \mathcal{Y}_{\alpha}$ , which is outside  $\mathcal{Y}_{\alpha}$ ,  $c_{\alpha}f_{0}(y) > f_{1}(y)$ .

We have that

$$\int_{\mathcal{Y}_{\alpha}\setminus\mathcal{Y}_{1}} f_{1}(y)dy \geq c_{\alpha} \int_{\mathcal{Y}_{\alpha}\setminus\mathcal{Y}_{1}} f_{0}(y)dy = c_{\alpha} \int_{\mathcal{Y}_{1}\setminus\mathcal{Y}_{\alpha}} f_{0}(y)dy \geq \int_{\mathcal{Y}_{1}\setminus\mathcal{Y}_{\alpha}} f_{1}(y)dy$$

with strict inequality unless the regions are equivalent

Then

$$\int_{\mathcal{Y}_{\alpha}} f_1(y) dy \ge \int_{\mathcal{Y}_1} f_1(y) dy$$

thus the power of  $\mathcal{Y}_{\alpha}$  is at least that of  $\mathcal{Y}_{1}$ 

Note that if  $\mathcal{Y}_1$  had been of size less than  $\alpha$  the final inequality holds

Let  $Y_1, \ldots, Y_n$  be i.i.d.  $N(\mu, 1)$ . Consider

$$H_0: \mu = \mu_0, \quad H_1: \mu = \mu_1$$

with  $\mu_1 > \mu_0$ .

$$lr(y) = \exp\left\{n\bar{y}(\mu_1 - \mu_0) - \frac{1}{2}n\mu_1^2 + \frac{1}{2}n\mu_0^2\right\}$$

Because all quantities, except for  $\bar{y}$ , are fixed constants, and because  $\mu_1 - \mu_0 > 0$ , a critical region of the form  $\ln(y) \ge c_\alpha$  is equivalent to one of the form  $\bar{y} \ge d_\alpha$ . Since  $\bar{Y} \stackrel{H_0}{\sim} N(\mu_0, 1/n)$ 

$$d_{\alpha} = \mu_0 + \frac{z_{\alpha}}{\sqrt{n}}$$

where  $z_{\alpha}$  is the  $1 - \alpha$  quantile of N(0, 1), and

$$\mathcal{Y}_{\alpha}^{+} = \{y_1, \ldots, y_n : \sqrt{n}(\bar{y} - \mu_0) \ge z_{\alpha}\}$$

Let  $Y_1, \ldots, Y_n$  be i.i.d. in the single parameter exponential family

$$\exp\{a(\theta)b(y) + c(\theta) + d(y)\}\$$

among them the normal, gamma, binomial and Poisson distribution, and that the hypotheses are  $H_0: \theta=\theta_0$  and  $H_1: \theta=\theta_1$  Then the likelihood ratio involves the data only through the sufficient statistic  $S=\sum b(Y_j)$  and the best critical region has the form

$$\exp\{a(\theta_1) - a(\theta_0)\} s \ge e_\alpha$$

If  $a(\theta_1)-a(\theta_0)>0$ , this is equivalent to  $s\geq \tilde{e}_\alpha$ , the critical region being the same for all such  $\theta_1$ 

Let  $Y \sim \text{Poisson}(\lambda)$ . Consider

$$H_0: \lambda = 1, \quad H_1: \lambda = \lambda_1 > 1$$

The likelihood critical regions have the form  $y \ge d_{\alpha}$ 

However, because *Y* is discrete, the only critical regions are of the form  $y \ge r$ , where *r* is an integer

$$r$$
 0 1 2 3 4 5 6  $\operatorname{pr}_0(Y \ge r)$  1 0.632 0.264 0.08 0.0189 0.0037 0.0006

If  $\alpha$  is one of the values above, a likelihood ratio region of the required size does exist.

By a mathematical artifice, it is, however, possible to achieve likelihood ratio critical regions with other values of  $\alpha$ 

Suppose that  $\alpha=0.05$ . The region  $y\geq 4$  is too small, whereas the region  $y\geq 3$  is too large. All values  $y\geq 4$  are put in the critical region, whereas if y=3 we regard the data as in the critical region with probability  $\pi$  such that

$$\mathrm{pr}_0(\mathit{Y} \geq 4) + \pi \cdot \mathrm{pr}_0(\mathit{Y} = 3) = 0.05$$

leading to  $\pi=0.51$ . This is a randomized critical region of size 0.05.

The randomized definition of  $p_{obs}$  corresponding to Y = y is

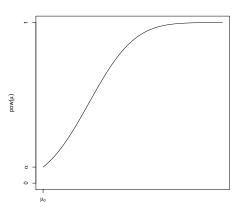
$$\operatorname{pr}_0(Y > y) + U \cdot \operatorname{pr}_0(Y = y)$$

where  $U \sim \text{Uniform}(0, 1)$ , independently of Y. The corresponding random variable is, under  $H_0$ , Uniform(0, 1).

# Composite alternatives

Suppose  $H_0: \theta = \theta_0$  and  $H_1: \theta \in \Theta_1$ . Two cases now arise.

- We get the same size α best critical region for all θ ∈ Θ<sub>1</sub>. Then we say that the region is *uniformly most powerful* size α region. If this holds for each α, then the test itself is called uniformly most powerful (UMP).
- The best critical region depends on the particular  $\theta \in \Theta_1$ . Then no uniformly most powerful exists. One possibility is to take  $\theta \in \Theta_1$  very close to  $\theta_0$ , to maximize the power locally near the null hypothesis.



 $Y_1, \ldots, Y_n$  be i.i.d.  $N(\mu, 1)$ . Test  $H_0: \mu = \mu_0$  against  $H_1: \mu > \mu_0$  with critical region  $\mathcal{Y}_{\alpha}^+ = \{y_1, \ldots, y_n: \sqrt{n}(\bar{y} - \mu_0) \geq z_{\alpha}\}$ 

$$pow(\mu;\alpha) = \Phi(\sqrt{n}(\mu - \mu_0) - z_\alpha)$$

#### Two-sided tests

Let  $Y_1, \ldots, Y_n$  be i.i.d.  $N(\mu, 1)$ . Test  $H_0: \mu = \mu_0$  against  $H_1: \mu < \mu_0$  with critical region  $\mathcal{Y}_{\alpha}^- = \{y_1, \ldots, y_n: \sqrt{n}(\bar{y} - \mu_0) \leq -z_{\alpha}\}$ 

Suppose now that we wish to test  $H_0: \mu = \mu_0$  against  $H_1: \mu \neq \mu_0$ .

The critical region

$$\mathcal{Y}_{\alpha} = \mathcal{Y}_{\alpha}^{-} \cup \mathcal{Y}_{\alpha}^{+}$$

has size  $2\alpha$ , and no uniformly more powerful test exists for the two-sided alternative.

A critical region  $\mathcal{Y}_{\alpha}$  of size  $\alpha$  is called *unbiased* if

$$\operatorname{pr}(Y \in \mathcal{Y}_{\alpha}; \theta) \ge \operatorname{pr}(Y \in \mathcal{Y}_{\alpha}; \theta_0) \quad \forall \ \theta \in \Theta_1$$

One may restrict attention to unbiased regions and among these look for the one with maximum power

A test which is uniformly most powerful amongst the class of all unbiased tests is *uniformly most powerful unbiased* (UMPU)

Suppose  $Y = (Y_1, \dots, Y_m)^t$  is multivariate normal with mean vector  $\mu = (\mu_1, \dots, \mu_m)^t \geq 0$  and known nonsingular covariance matrix  $\Sigma$ 

For testing  $H_0: \mu = 0$  against  $H_1: \mu = \mu_1$ , the most powerful test rejects for large values of

$$\mu_1^t \Sigma^{-1} Y$$

In particular, no UMP test exists

For testing  $H_0: \mu=0$  against  $H_1: \mu=(k,\ldots,k)^t$  for k>0, a UMP test exists and rejects for large values of the sum of the components of  $\Sigma^{-1}Y$ . If, in particular,  $\Sigma$  has diagonal elements 1 and off-diagonal elements  $\rho$ , then the test rejects when

$$\sum_{i} Y_i \ge z_{\alpha} (m + m(m-1)\rho)^{1/2}$$

# Locally most powerful tests

Let  $f_0(y) = f(y; \theta_0)$  and  $f_1(y) = f(y; \theta_1)$  with  $\theta_1 = \theta_0 + \epsilon$  for small  $\epsilon > 0$ 

$$\log \operatorname{lr}(y) = \log \frac{f(y; \theta_0 + \epsilon)}{f(y; \theta_0)}$$

$$= \log f(y; \theta_0 + \epsilon) - \log f(y; \theta_0)$$

$$= \epsilon \frac{\partial \log f(y; \theta_0)}{\partial \theta_0} + \dots$$

Then the appropriate test statistic is the score

$$U(\theta_0) = \frac{\partial \log f(Y; \theta_0)}{\partial \theta_0}$$

Its null distribution has mean o and variance  $i(\theta_0)$ , the Fisher information

Let  $Y_1, \ldots, Y_n$  be i.i.d. in the Cauchy distribution

$$\frac{1}{\pi[1+(y-\theta)^2]}$$

For the null hypothesis  $H_0: \theta = \theta_0$  the score from  $Y_1$  is

$$U_1(\theta_0) = \frac{2(Y_1 - \theta_0)}{1 + (Y_1 - \theta_0)^2}$$

and the information from a single observation is

$$i_1(\theta_0) = \frac{1}{2}$$

The test statistic is thus

$$U(\theta_0) = 2\sum_{i=1}^{n} \frac{(Y_i - \theta_0)}{1 + (Y_i - \theta_0)^2}$$

Its null distribution has mean o and variance n/2

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